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| Form PTO-1449 (modified) | Atty. Docket No. 2000.088500/TT4616 | Serial No. 10/700,175 |
| List of Patents and Publications for Applicant's INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary) | Applicant Elfido Coss, Jr., Patrick M. Cowan, Richard J. Markle and Tom Tse | |
| | Filing Date: November 3, 2003 | Group: 2812 2881 |
| U.S. Patent Documents See Page 1 | Foreign Patent Documents See Page 1 | Other Art See Page 1 |

U.S. Patent Documents

| Exam. Init. | Ref. Des. | Document Number | Date | Name | Class | Sub Class | Filing Date of App. |
|----------------|--------------|--------------------|---------|------------------------|-------|--------------|------------------------|
| 115 | A2 | 6,055,460 | 4/25/00 | Shopbell | 700 | 121 | |
| 115 | A3 | 2002/0055801 A1 | 5/09/02 | Reiss <i>et al.</i> | 700 | 111 | |
| 115 | A4 | 2003/0042427 A1 | 3/06/03 | Sullivan <i>et al.</i> | 250 | 397 | |
| | A5 | | | | | | |
| | A6 | | | | | | |

Foreign Patent Documents

| Exam. Init. | Ref. Des. | Document Number | Date | Country | Class | Sub Class | Translation Yes/No |
|----------------|--------------|--------------------|------|---------|-------|--------------|-----------------------|
| | B1 | | | | | | |
| | B2 | | | | | | |
| | B3 | | | | | | |

Other Art (Including Author, Title, Date Pertinent Pages, Etc.)

| Exam. Init. | Ref. Des. | Citation |
|----------------|--------------|---------------------------------------------------------------------------------------------------------------------------------|
| 115 | C1 | PCT Search Report from PCT/US2004/017617, dated 12/02/04 |
| 115 | C2 | Rendon <i>et al.</i> , "Ion Implant Data Log Analysis for Process Control and Fault Detection," <i>IEEE</i> , pp. 331-334, 2002 |
| | C3 | |

EXAMINER:

DATE CONSIDERED:

May 4, 2005

EXAMINER: INITIAL IF REFERENCE CONSIDERED, WHETHER OR NOT CITATION IS IN CONFORMANCE WITH MPEP609; DRAW LINE THROUGH CITATION IF NOT IN CONFORMANCE AND NOT CONSIDERED. INCLUDE COPY OF THIS FORM WITH NEXT COMMUNICATION TO APPLICANT.



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U.S. Patent Documents

| Exam. Init. | Ref. Des. | Document Number | Date | Name | Class | Sub Class | Filing Date of App. |
|----------------|--------------|--------------------|----------|-------------------------|-------|--------------|------------------------|
| 115 | A1 | 6,465,263 B1 | 10/15/02 | Coss, Jr. <i>et al.</i> | 438 | 14 | |
| | A2 | | | | | | |
| | A3 | | | | | | |
| | A4 | | | | | | |
| | A5 | | | | | | |

Foreign Patent Documents

| Exam. Init. | Ref. Des. | Document Number | Date | Country | Class | Sub Class | Translation Yes/No |
|----------------|--------------|--------------------|------|---------|-------|--------------|-----------------------|
| | B1 | | | | | | |
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EXAMINER:

Nichita Wells

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